

15. TEST SETUP PHOTOGRAPHS

FCC ID: A3LSMG935W8		HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename: 0Y151222206.A3L	Test Dates: 01/06/2015 - 01/12/2016	EUT Type: Portable Handset		Page 97 of 99

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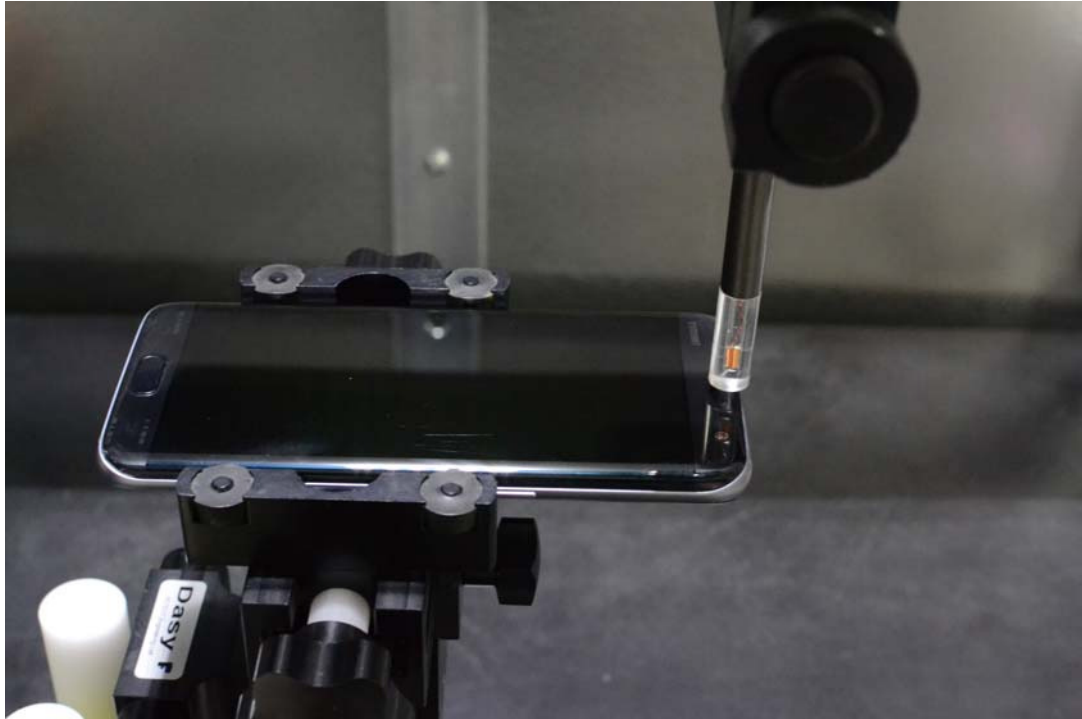


Figure 15-1
Test Setup for Wireless Device

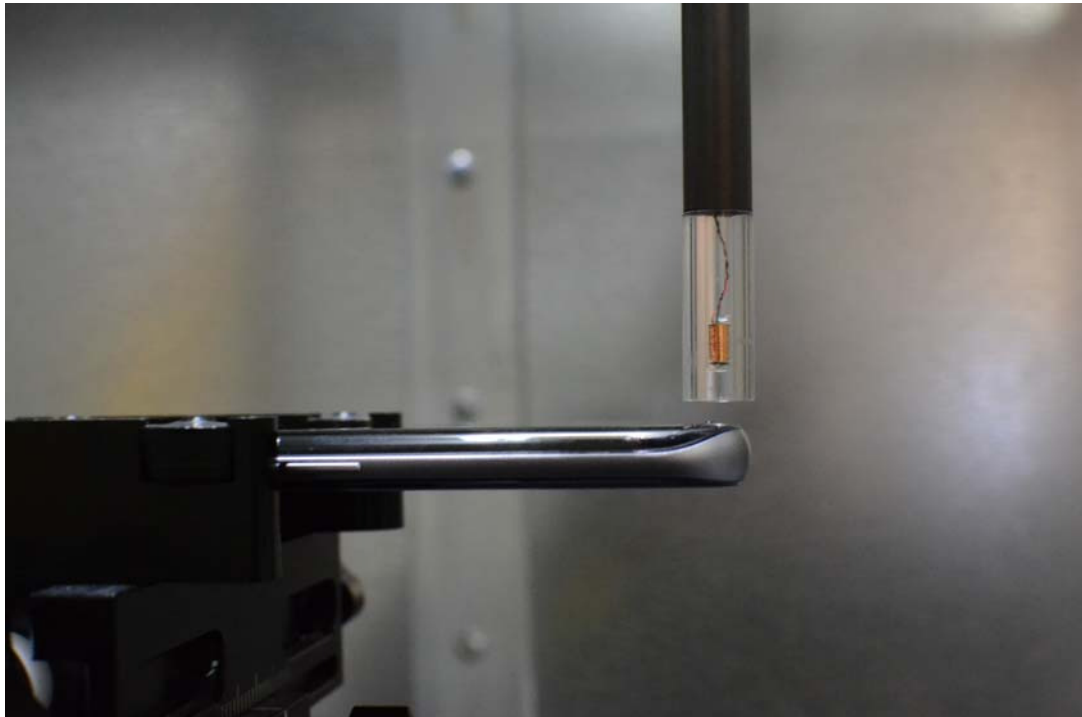


Figure 15-2
Test Setup for Wireless Device

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Figure 15-3
T-Coil Scan Overlay Magnetic Field Distributions

Note: Final measurement locations are indicated by a cursor on the contour plots.

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